

A²
detecting a defect of a pattern formed on said sample by
comparing an image signal obtained from the image of said
sample detected with the storage-type detector to a comparison
image signal stored beforehand.

✓
Claim 28, line 1, delete "for" insert --of--.

IN THE ABSTRACT OF THE DISCLOSURE:

Line 2, after "With" insert --a--;

line 2, after "with" insert --a--;

line 3, delete "constructed" insert --provided--.

REMARKS

The specification has been amended to correct errors of a typographical and grammatical nature. Due to the excessive corrections thereto, applicants submit herewith a Substitute Specification, along with a marked-up copy of the original specification for the Examiner's convenience. Applicants submit that the substitute specification includes no new matter. Therefore, entry of the Substitute Specification is respectfully requested.

The claims have also been amended to more clearly describe the features of the present invention, and the abstract has been amended to correct grammatical errors therein.

Also submitted herewith are proposed amendment to the drawings. Upon receipt of the approval of the amendment to the drawings and receipt of a Notice of Allowance, the

proposed drawing corrections will be effected in accordance with present practice.

Entry of the preliminary amendments and examination of the application is respectfully requested.

To the extent necessary, applicant's petition for an extension of time under 37 CFR 1.136. Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account No. 01-2135 (501.38036X00) and please credit any excess fees to such deposit account.

Respectfully submitted,



Melvin Kraus
Registration No. 22,466
ANTONELLI, TERRY, STOUT & KRAUS, LLP

MK/DRA/cee
Attachments
(703) 312-6600

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